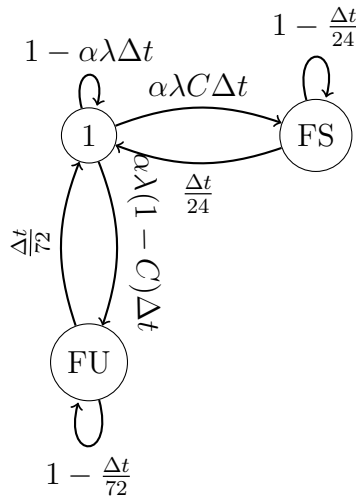


# Fault Tolerant Computing and VLSI Testing

## Assignment 3

1. The Markov Model for the system with self-diagnostics is:



- 1 is where the system is working successfully.
- FS is where a fault has been detected and the system has been safely deactivated.
- FU is where a fault has not been detected.

The Mean Time To Failure (MTTF) will be the amount of time we expect to stay in the working state. This is the value of  $t$  such that  $t\alpha\lambda = 1$ . This is equal to  $t = \frac{1}{\lambda\alpha}$

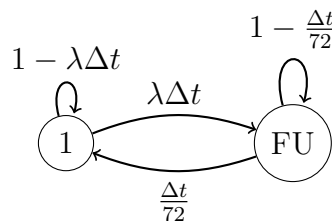
We detect the failure with probability 0.95, and don't with probability 0.05. This gives us a mean time between failures of:

$$0.95 * 24 + 0.05 * 72 = 26.4$$

Thus, the steady-state availability is:

$$A = \frac{1}{\alpha\lambda(\frac{1}{\alpha\lambda} + 26.4)} = \frac{1}{1 + 26.4\alpha\lambda}$$

The Markov Model for the system without self-diagnostics is:



- 1 is where the system is working successfully.
- FU is where a fault has occurred.

The MTTF is  $\frac{1}{\lambda}$  and the steady-state availability is:

$$A = \frac{1}{\lambda(\frac{1}{\lambda} + 72)} = \frac{1}{1 + 72\lambda}$$

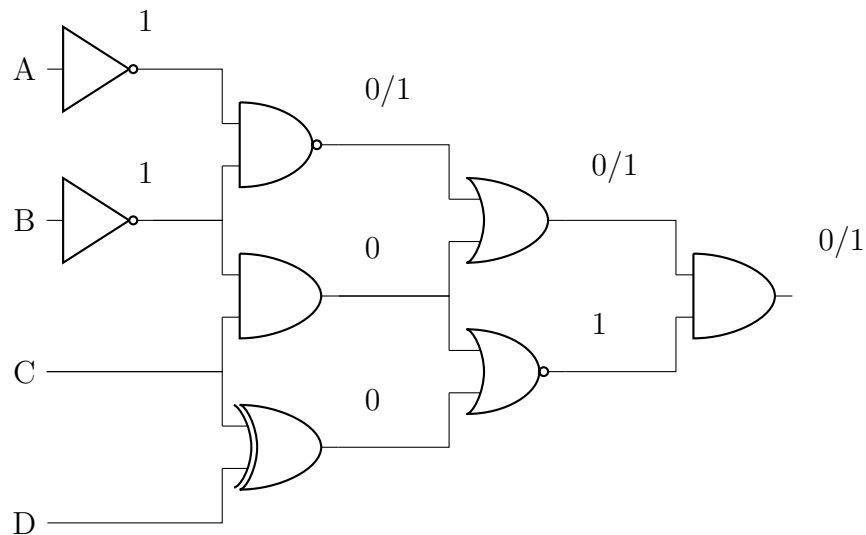
We can find the value of  $\alpha$  for which self-diagnostics begins to degrade the steady-state availability by equating these two equations:

$$\frac{1}{1 + 26.4\alpha\lambda} = \frac{1}{1 + 72\lambda} \implies 1 + 26.4\alpha\lambda = 1 + 72\lambda \implies 26.4\alpha\lambda = 72\lambda$$

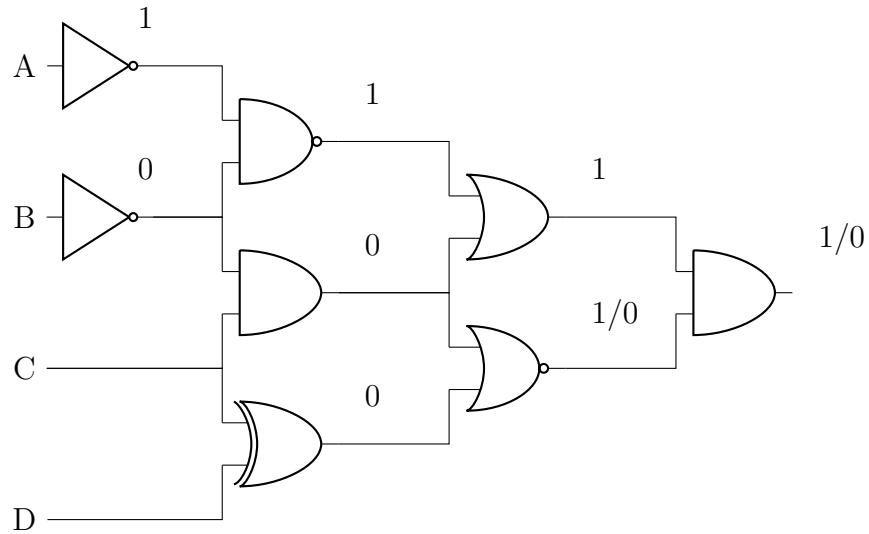
$$\alpha = \frac{72}{26.4} = 2.727$$

2. Test patterns are written as  $ABCD$

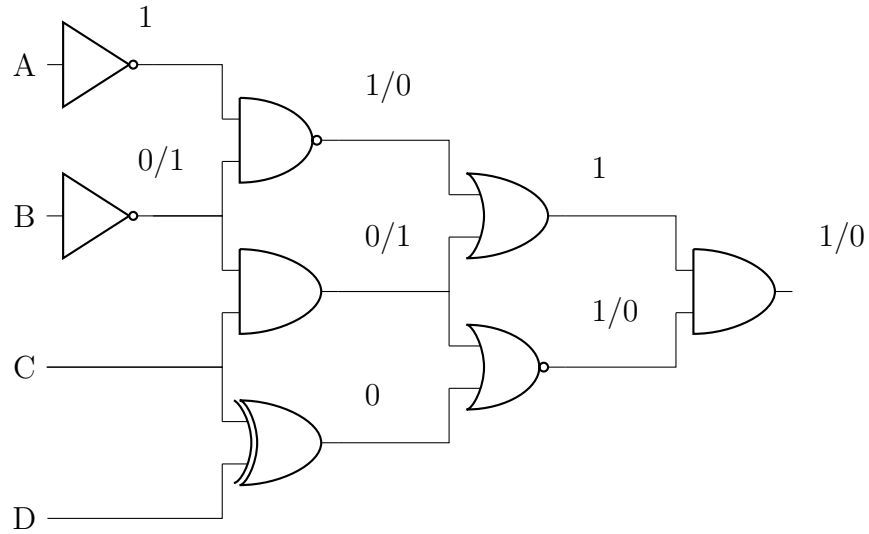
(i) 0000



(ii) 0100



(iii) 0111



$$3. \quad FC = 80\% \implies DL = 1 - 0.9^{1-0.8} = 0.020852 = 20852PPM$$

$$FC = 90\% \implies DL = 1 - 0.9^{1-0.9} = 0.010481 = 10481PPM$$

$$FC = 99\% \implies DL = 1 - 0.9^{1-0.99} = 0.001053 = 1053PPM$$

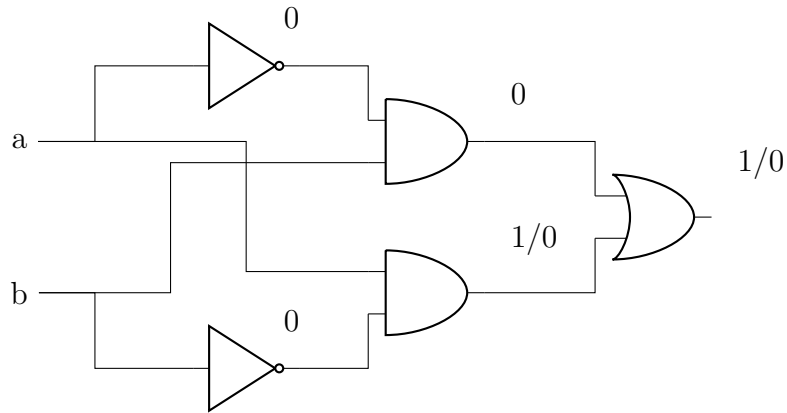
$$DL = 20PPM = 2 * 10^{-5} = 1 - 0.7^{1-FC}$$

$$0.6^{1-FC} = 1 - 2 * 10^{-5} = 0.99998$$

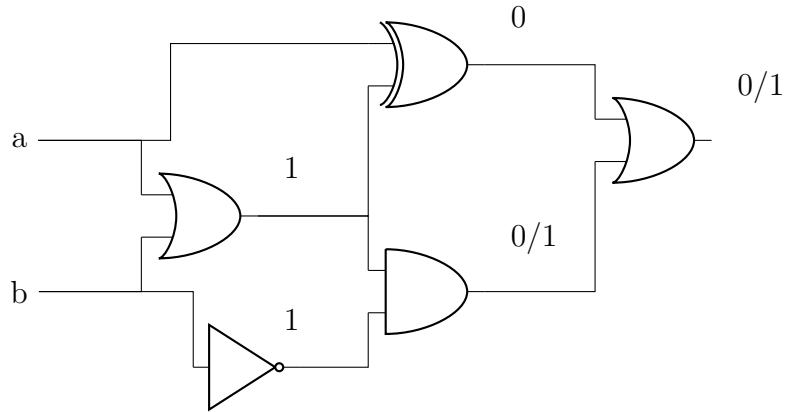
$$1 - FC = \log_{0.6} 0.99998 = 3.915 * 10^{-5}$$

$$FC = 1 - 3.915 * 10^{-5} = 0.99996 = 99.996\%$$





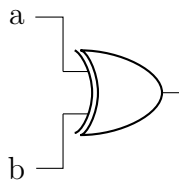
(2) 10:



As stated above, the operation is equivalent to:

$$\bar{a}b + a\bar{b} = a \oplus b$$

Therefore, the boolean operation this circuit is equivalent to is exclusive-OR. The minimum implementation is:



6. Test patterns are written as  $abc$ .

Not that a  $*$  symbol is used where appropriate to represent the AND operation for clarity, in order to help distinguish between, for example,  $\overline{a * c}$  and  $\bar{a} * \bar{c}$

(i)  $\bar{a} \frac{dz}{da} = \bar{a}(z(a = 1) \oplus z(a = 0)) = \bar{a}((\bar{c} + cb) \oplus cb)$

$$\begin{aligned}
 &= \bar{a}(\bar{c} + \bar{c}bcb + (\bar{c} + cb)\bar{c}\bar{b}) = \bar{a}(\bar{c}\bar{c}bcb + \bar{c}\bar{c}\bar{b} + cb\bar{c}\bar{b}) \\
 &= \bar{a} * \bar{c}\bar{c}\bar{b} = \bar{a} * \bar{c}(\bar{c} + \bar{b}) = \bar{a} * \bar{c} + \bar{a} * \bar{c}\bar{b} = \bar{a} * \bar{c}(1 + \bar{b}) = \bar{a} * \bar{c} = 1 \\
 &\text{The patterns } \{000, 010\} \text{ can detect the fault.}
 \end{aligned}$$

(ii)  $h \frac{dz}{dh} = h(z(h=1) \oplus z(h=0)) = h(1 \oplus a\bar{c}) = h\bar{a}\bar{c} = h(\bar{a} + c)$   
 $= h\bar{a} + hc$

Note that  $h = cb$ .

$$h \frac{dz}{dh} = \bar{a}bc + bc = bc(a + 1) = bc = 1$$

The patterns  $\{011, 111\}$  can detect the fault.

(iii)  $\bar{h} \frac{dz}{dh} = \bar{h}\bar{a} + \bar{h}c = \bar{c}\bar{b}\bar{a} + \bar{c}\bar{b}c = (\bar{c} + \bar{b})\bar{a} + (\bar{c} + \bar{b})c$   
 $= \bar{a}\bar{b} + \bar{a}\bar{c} + \bar{b}c + \bar{c}c = \bar{a}\bar{c} + \bar{a}\bar{c} + \bar{b}c = 1$

The patterns  $\{000, 001, 010, 101\}$  can detect the fault.

(iv)  $e \frac{dz}{de} = e(z(e=1) \oplus z(e=0)) = e((a\bar{c} + b) \oplus a\bar{c})$   
 $= e(\bar{a}\bar{c} + \bar{b}a\bar{c} + (a\bar{c} + b)\bar{a}\bar{c}) = e(\bar{b} * \bar{a}\bar{c}a\bar{c} + a\bar{c}a\bar{c} + \bar{b}a\bar{c}) = e\bar{b}a\bar{c}$   
 $= be(\bar{a} + c) = \bar{a}be + bec$

Note that  $e = c$ .

$$e \frac{dz}{de} = \bar{a}bc + bc = bc(\bar{a} + 1) = bc = 1$$

The patterns  $\{011, 111\}$  can detect the failure.

(v)  $\bar{e} \frac{dz}{de} = \bar{a}\bar{b}\bar{e} + \bar{b}\bar{e}c = \bar{a}\bar{b}\bar{c} + \bar{b}c\bar{c} = \bar{a}\bar{b}\bar{c}$

The pattern  $\{010\}$  can detect the failure.

(vi)  $c \frac{dz}{dc} = c(z(c=1) \oplus z(c=0)) = c(b \oplus a) = c(\bar{a}b + a\bar{b}) = \bar{a}bc + a\bar{b}c = 1$   
The patterns  $\{011, 101\}$  can detect the fault.

7. Test patterns are written as  $ab$ .

(a)  $\bar{a} \frac{di}{da} = \bar{a}(i(a=1) \oplus i(a=0)) = \bar{a}(b \oplus 0) = \bar{a}b = 1$

The pattern  $\{01\}$  can detect the fault.

(b)  $\bar{d} \frac{di}{da} = \bar{d}(i(d=1) \oplus i(d=0)) = \bar{d}(ab \oplus 0) = \bar{d}ab$

Note that  $d = a$ .

$$\bar{d} \frac{di}{da} = \bar{a}ab = 0 = 1$$

We have reached a contradiction, therefore this fault cannot be detected.

(c)  $\bar{g} \frac{di}{dg} = \bar{g}(i(g=1) \oplus i(g=0)) = \bar{g}(ab \oplus 0) = \bar{g}ab$

Note that  $g = ab$ .

$$\bar{g} \frac{di}{dg} = \bar{a}bab = 0 = 1$$

We have reached a contradiction, therefore this fault cannot be detected.

8. Below are the signatures calculated for the sequence  $M = 10011011$  (fault-free) and the faulty sequence  $M' = 11111111$

$M$	$R_1$	$R_2$	$R_3$	$R_4$	$M'$	$R_1$	$R_2$	$R_3$	$R_4$
1	0	0	0	0	1	0	0	0	0
1	1	0	0	0	1	1	0	0	0
0	1	1	0	0	1	1	1	0	0
1	0	1	1	0	1	1	1	1	0
1	1	0	1	1	1	1	1	1	1
0	0	0	0	1	1	0	0	1	1
0	1	1	0	0	1	0	1	0	1
1	0	1	1	0	1	0	1	1	0
$R$	1	0	1	1	$R$	1	0	1	1

The signature for the faulty sequence  $M'$  matches the signature for the fault-free sequence  $M$ , so this fault is not detected.